SCBS727 – JULY 2000

•	BiCMOS Technology With Low Quiescent Power			CKAGE VIEW)	
•	Buffered Inputs	OE [	1	$\bigcup_{24}$	] v <sub>cc</sub>
•	Noninverted Outputs	1D [	2	23	] 1Q
•	Input/Output Isolation From V <sub>CC</sub>	2D [	3	22	2Q
•	Controlled Output Edge Rates	3D [	4		3Q
•	48-mA Output Sink Current		5	1	4Q
	•		6	1	5Q
	Output Voltage Swing Limited to 3.7 V	6D L	7	18	6Q
•	SCR Latch-Up-Resistant BiCMOS Process	7D [	8	17	7Q
	and Circuit Design	8D [	9	16	8Q
•	Packaged in Plastic Small-Outline Package	9D [	10	15	9Q
		CLR	11	14	PRE
desc	ription	GND [	12	13	] LE

The CD74FCT843A is a 9-bit, bus-interface, D-type latch with 3-state outputs, designed

specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below  $V_{CC}$ . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes  $V_{CC}$  bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

The CD74FCT843A outputs are transparent to the inputs when the latch-enable (LE) input is high. The latches are transparent D-type latches. When LE goes low, the data is latched. The output-enable  $(\overline{OE})$  input controls the 3-state outputs. When  $\overline{OE}$  is high, the outputs are in the high-impedance state. The latch operation is independent of the state of the output enable. This device, having preset  $(\overline{PRE})$  and clear  $(\overline{CLR})$ , are ideal for parity-bus interfacing. When  $\overline{PRE}$  is low, the outputs are high if  $\overline{OE}$  is low.  $\overline{PRE}$  overrides  $\overline{CLR}$ . When  $\overline{CLR}$  is low, the outputs are low if  $\overline{OE}$  is low. When  $\overline{CLR}$  is high, data can be entered into the latch. The device provides noninverted outputs.

OE does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

The CD74FCT843A is characterized for operation from 0°C to 70°C.

# FUNCTION TABLE (each latch)

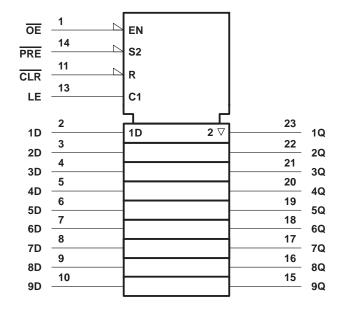
	INPUTS						
PRE	CLR	OE	LE	D	Q		
L	Х	L	Х	Χ	Н		
Н	L	L	X	Χ	L		
Н	Н	L	Н	L	L		
Н	Н	L	Н	Н	Н		
Н	Н	L	L	Χ	Q <sub>0</sub>		
Χ	X	Н	X	Χ	Z		



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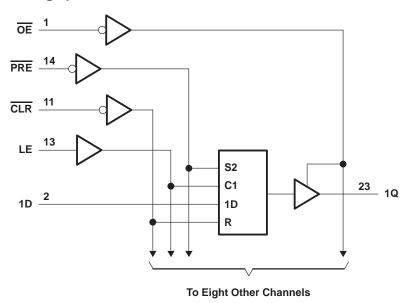


## logic symbol†



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)





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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

DC supply voltage range, V <sub>CC</sub>	0.5 V to 6 V
DC input clamp current, $I_{IK}$ ( $V_I < -0.5 \text{ V}$ )	–20 mA
DC output clamp current, I <sub>OK</sub> (V <sub>O</sub> < -0.5 V)	
DC output sink current per output pin, I <sub>OL</sub>	70 mA
DC output source current per output pin, I <sub>OH</sub>	–30 mA
Continuous current through V <sub>CC</sub> , (I <sub>CC</sub> )	237 mA
Continuous current through GND	
Package thermal impedance, θ <sub>JA</sub> (see Note 1)	46°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
Vcc	Supply voltage	4.75	5.25	V
VIH	High-level input voltage	2		V
V <sub>IL</sub>	Low-level input voltage		0.8	V
٧ı	Input voltage	0	VCC	V
٧o	Output voltage	0	VCC	V
IOH	High-level output current		-15	mA
loL	Low-level output current		48	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# electrical characteristics over recommended operating temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Voc	T <sub>A</sub> = 25°C	MIN	MAX	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN MAX	IVIIIN		UNIT
VIK	$I_{I} = -18 \text{ mA}$	4.75 V	-1.3	2	-1.2	V
VOH	$I_{OH} = -15 \text{ mA}$	4.75 V	2.4	2.4		V
V <sub>OL</sub>	$I_{OL} = 48 \text{ mA}$	4.75 V	0.5	5	0.55	V
lį	$V_I = V_{CC}$ or GND	5.25 V	±0.		±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.25 V	±0.	5	±10	μΑ
los <sup>‡</sup>	$V_I = V_{CC}$ or GND, $V_O = 0$	5.25 V	<del>-</del> 75	-75		mA
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.25 V		3	80	μΑ
ΔlCC§	One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.25 V	1.0	5	1.6	mA
Ci	$V_I = V_{CC}$ or GND		10	)	10	pF
Co	$V_O = V_{CC}$ or GND		1:	5	15	pF

<sup>‡</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.



NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

<sup>§</sup> This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or VCC.

## CD74FCT843A BiCMOS 9-BIT BUS-INTERFACE D-TYPE LATCH WITH 3-STATE OUTPUTS

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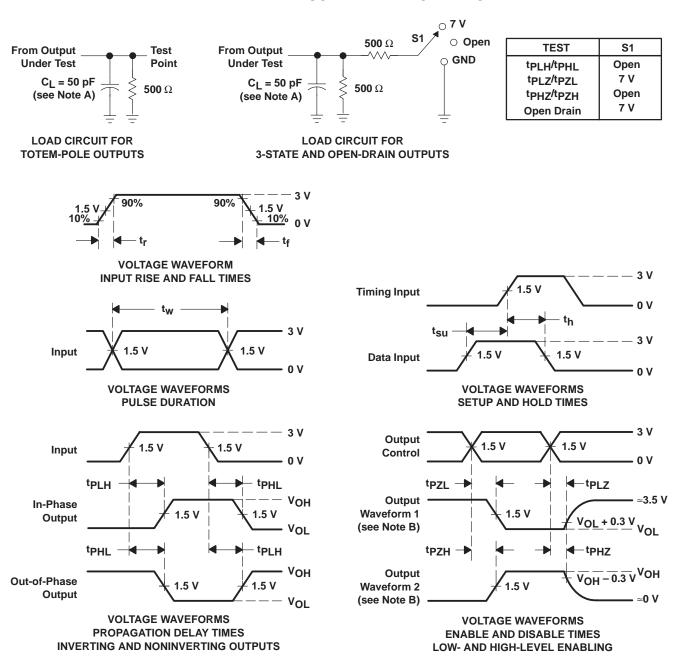
# timing requirements over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT
		CLR low	8		
t <sub>W</sub>	Pulse duration	PRE low	8		ns
		LE low	4		
		Data before LE↓	2.5		
t <sub>su</sub>	Setup time	PRE inactive	1.4		ns
		CLR inactive	1.4		
t <sub>h</sub>	Hold time	Data before LE↓	2.5		ns
t <sub>rec</sub>	Recovery time	PRE, CLR	14		ns

# switching characteristics over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T <sub>A</sub> = 25°C	MIN	MAX	UNIT
	D	, ,	6.8	1.5	9	
<sup>t</sup> pd	LE	Q	9	1.5	12	ns
<sup>t</sup> PLH	PRE	Q	9	1.5	12	ns
<sup>t</sup> PHL	CLR	Q	9.8	1.5	13	ns
t <sub>en</sub>	ŌĒ	Q	10.5	1.5	14	ns
<sup>t</sup> dis	ŌĒ	Q	6	1.5	8	ns

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f$  and  $t_f = 2.5$  ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpHL and tpLH are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
CD74FCT843AM	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	74FCT843AM
CD74FCT843AM.A	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	74FCT843AM

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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### **TUBE**



### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD74FCT843AM	DW	SOIC	24	25	506.98	12.7	4826	6.6
CD74FCT843AM.A	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

## PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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